

Notice of References Cited

Application/Control No.

10/042,143

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,593,282 A	06-1986	Acampora et al.	370/447
*	B	US-5,572,678 A	11-1996	Homma et al.	709/227
*	C	US-5,734,867 A	03-1998	Clanton et al.	370/461
*	D	US-6,009,468 A	12-1999	Lau et al.	709/225
*	E	US-6,137,793 A	10-2000	Gorman et al.	370/360
*	F	US-6,532,279 B1	03-2003	Goodman, David D.	379/90.01
*	G	US-6,563,816 B1	05-2003	Nodoushani et al.	370/352
*	H	US-6,636,518 B1	10-2003	Lienres, Bjorn O.	370/395.7
*	I	US-6,661,849 B1	12-2003	Guo et al.	375/261
*	J	US-6,671,276 B1	12-2003	Bakre et al.	370/395.1
*	K	US-6,674,765 B1	01-2004	Chuah et al.	370/458
*	L	US-6,701,406 B1	03-2004	Chang et al.	710/310
*	M	US-6,711,138 B1	03-2004	Pai et al.	370/257

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,731,627 B1	05-2004	Gupta et al.	370/352
*	B	US-6,732,315 B2	05-2004	Yagil et al.	714/755
*	C	US-6,747,959 B1	06-2004	Ho, Jin-Meng	370/282
*	D	US-6,747,996 B2	06-2004	Holloway et al.	370/503
*	E	US-6,765,927 B1	07-2004	Martin et al.	370/469
*	F	US-6,778,549 B1	08-2004	Keller, Philip J	370/430
*	G	US-6,778,646 B1	08-2004	Sun, Ting	379/93.05
*	H	US-6,781,989 B1	08-2004	Acharya, Yatin	370/392
*	I	US-6,801,541 B1	10-2004	Maleck, Timothy C.	370/466
*	J	US-6,804,222 B1	10-2004	Lin et al.	370/338
*	K	US-6,810,520 B2	10-2004	Lu et al.	719/310
*	L	US-6,839,345 B2	01-2005	Lu et al.	370/365
*	M	US-6,850,981 B1	02-2005	Ho et al.	709/227

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,862,270 B1	03-2005	Ho, Jin-Meng	370/328
*	B	US-6,862,280 B1	03-2005	Bertagna, Drew	370/392
*	C	US-6,862,630 B1	03-2005	Garg et al.	709/250
*	D	US-6,868,072 B1	03-2005	Lin et al.	370/276
*	E	US-6,877,043 B2	04-2005	Mallory et al.	709/251
*	F	US-6,882,634 B2	04-2005	Bagchi et al.	370/338
*	G	US-6,888,844 B2	05-2005	Mallory et al.	370/466
*	H	US-6,891,881 B2	05-2005	Trachewsky et al.	375/143
*	I	US-6,894,999 B1	05-2005	Acharya, Yatin	370/352
*	J	US-6,898,204 B2	05-2005	Trachewsky et al.	370/445
*	K	US-6,909,725 B1	06-2005	Chow, Peter Ka-Fai	370/467
*	L	US-6,922,407 B2	07-2005	Wu, Song	370/355
*	M	US-6,925,089 B2	08-2005	Chow et al.	370/419

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,928,057 B2	08-2005	Bullman et al.	370/252
*	B	US-6,940,918 B1	09-2005	Nayler et al.	375/295
*	C	US-6,947,438 B1	09-2005	Chang et al.	370/419
*	D	US-6,947,480 B2	09-2005	Beale et al.	375/229
*	E	US-6,950,397 B1	09-2005	Ho et al.	370/235
*	F	US-6,954,800 B2	10-2005	Mallory, Tracy D.	709/240
*	G	US-6,961,344 B1	11-2005	Gaspar et al.	370/447
*	H	US-6,963,545 B1	11-2005	Ho, Jin-Meng	370/282
*	I	US-6,970,422 B1	11-2005	Ho et al.	370/230
*	J	US-6,975,655 B2	12-2005	Fischer et al.	370/516
*	K	US-6,988,236 B2	01-2006	Ptasinski et al.	714/758
*	L	US-6,999,442 B1	02-2006	Ho et al.	370/338
*	M	US-7,000,031 B2	02-2006	Fischer et al.	709/248

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	U					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,006,517 B1	02-2006	Ben Michael et al.	370/445
*	B	US-7,031,274 B2	04-2006	Sherman, Matthew J.	370/321
*	C	US-7,031,287 B1	04-2006	Ho et al.	370/338
*	D	US-7,035,285 B2	04-2006	Holloway et al.	370/474
*	E	US-7,039,032 B1	05-2006	Ho et al.	370/338
*	F	US-7,068,649 B2	06-2006	Fisher et al.	370/355
*	G	US-7,142,563 B1	11-2006	Lin, Wei	370/469
*	H	US-7,180,855 B1	02-2007	Lin, Wei	370/230
*	I	US-7,293,103 B1	11-2007	Lin et al.	709/236
*	J	US-7,298,757 B1	11-2007	Lin et al.	370/447
*	K	US-7,310,326 B1	12-2007	Lin et al.	370/348
*	L	US-2002/0012343 A1	01-2002	Holloway et al.	370/389
*	M	US-2002/0026523 A1	02-2002	Mallory et al.	709/236

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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2446

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0027886 A1	03-2002	Fischer et al.	370/255
*	B	US-2002/0042836 A1	04-2002	Mallory, Tracy D.	709/232
*	C	US-2002/0057717 A1	05-2002	Mallory, Tracy D.	370/503
*	D	US-2002/0078247 A1	06-2002	Lu et al.	709/251
*	E	US-2002/0078249 A1	06-2002	Lu et al.	709/310
*	F	US-2002/0163932 A1	11-2002	Fischer et al.	370/465
*	G	US-2007/0064720 A1	03-2007	Sterenson et al.	370/445
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

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